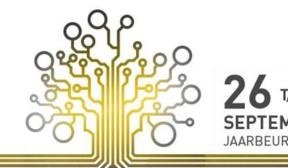
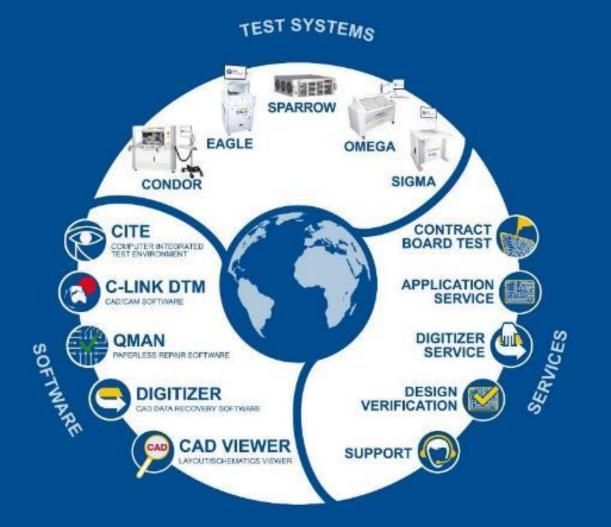
# ECO on the fly E&A 2023

Fight against obsolete Components and ECO's









"Since 1980, Digitaltest has been developing and manufacturing automated test systems (ATE) for electronic circuit boards, software for production automation and quality management systems."

#### Experiences



automation



information technology



Computers & Peripherals



medical technology



automobile industry



industrial electronics



Contract manufacturer



consumer electronics



Military



test houses



Aerospace technology



# 1. The world wide supply chain

Components Profit margin Orders decreases **Production** Negative impact cannot be or become stand still full filled! even no profit Processes are jeopardized

Non available

# 1. The world wide supply chain

Consequences and negative effects in all areas!

Cost of Components are increasing

Penalties for breach of contract loom Layouts and Circuitries need to be changed

Even in the field of testing!





# Test Programs

- ✓ layout change leads to **change the existing test program**
- ✓ modification of existing program needs extra time and stops production for the time of creation and debugging
- ✓ complete new test program leads to longer production times and higher production cost







### Adjust Fixtures

change the existing fixture

for modification

risk to create new problems

cost of fixture adjustment

risk of shipping the fixture







### **Build New Fixtures**

lead time on building a new fixture

extra cost, extremely expensive solution



risk to create new problems, new fixture debugging needed

new fixture and new PCB's need to be on time for production











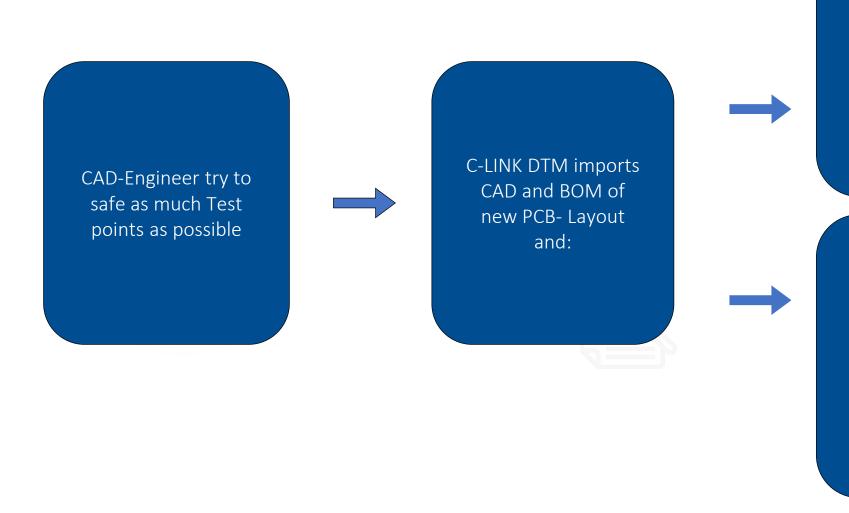
# 2. The Solution: ECO on the Fly







# 2. ECO on the Fly: work flow



1.

Recommends how the existing fixture can be saved and modified. How the test program can be modified

2

Generates Data for the Flying Probe Test system, in order to test the no more covered components after the Layout change





Test Scenario: Example

fixture and test program already in use

ECO due to obsolescence of component

Fixture: some test pins need to be pulled and new test points require new test points consequence of this is that the test depth can no longer be maintained without building a new adapter





# 2. ECO on the Fly: Example

PCB Rev. 1: Test Coverage 90 %

PCB Rev. 2: Flying Probe Test Coverage 15 %, Bed of Nails 82 %









Higher Test Coverage of 97 %

Throughput will not be affected





#### Test Scenario: The development team manages to keep 80% of the existing test points

20% can no longer be contacted by fixture pins

20% are now checked on the flying prober solution

with combination of flying probe and ICT, a maximum test depth is achieved

time balance between 80% test on fast ICT and 20% test on slower flying probers could work

existing fixture can continue to be used, there are no new adapter costs

change can be made quickly and offers a high degree of flexibility





#### Advantages of Combination of ICT and Flying Prober

test programs on both systems run in the same software environment

test system ICT or flying probe is based on the same measurement modules

if there is no fixture available, the flying prober can also be used as a "prototype tester"

less need for test points because nets without test points are then tested on the flying prober

no new fixture costs

future changes and obsolescence can be handed quickly and offers a high degree of flexibility





# 3. Advantages

Lack of test coverage due to reduced fixture access is compensated by a flying probe test program

**Existing fixtures** still can be used

Most possible increase of test coverage

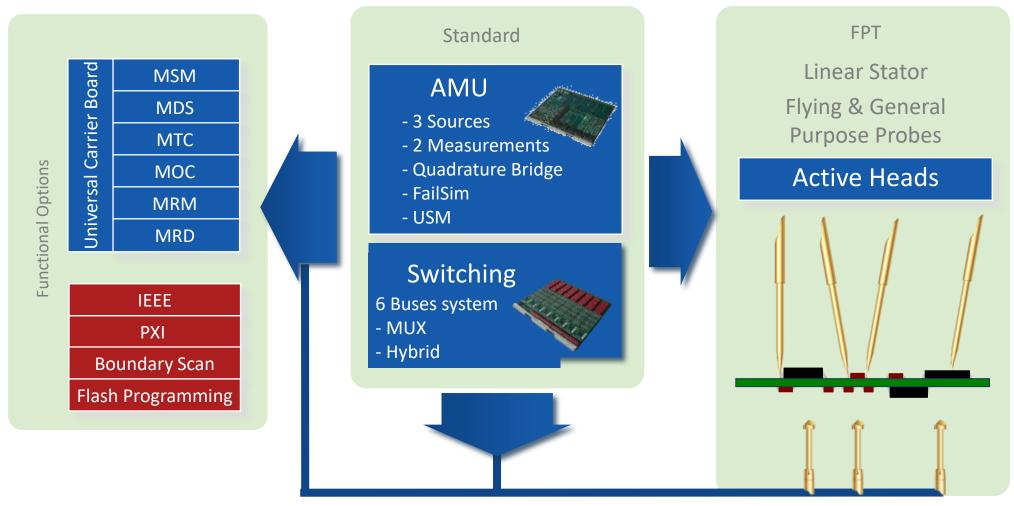
Test
equipment
adapted to
new PCB in a
short time

The combination of needle bed and flying probe test keeps cycle time low and avoids bottlenecks





## System Architecture





**Direct Connection or Switched through movable General Purpose Probes** 

## 3. At a glance

Test programs on both systems run on the same software environment

Testsystem ICT or Flying Probe using the same hardware modules

Perfect combination for the best result!

"The battle for test points" eases as nets without test points are tested on the Flying Probe

Flying Probe can be used also for Prototyping or NPI

Instead of an (expensive) 2-sided fixture, a single-sided fixture plus flying probe can be used





## Advantage ECO on the Fly

With only one new test station it is possible to to cope with all ECOs that occur on different assemblies



This allows us to react flexibly and quickly to obsolescence's, supply chain problems and component bottlenecks in the future



# Thank you very much for your attention

See you on the booth at stand no. 7C130





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